

TOSHIBA BIPOLAR LINEAR INTEGRATED CIRCUIT SILICON MONOLITHIC

# TA2109F

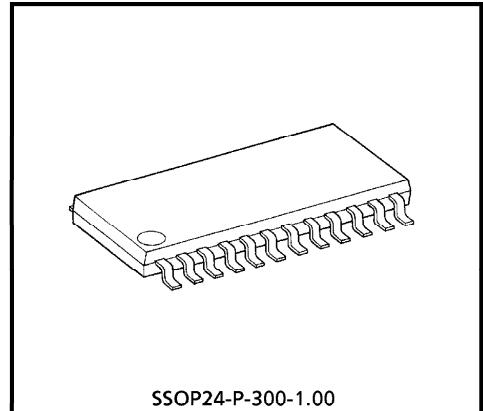
## RF AMPLIFIER FOR DIGITAL SERVO CD SYSTEM

TA2109F is a 3-beam type PUH compatible RF Amplifier for Digital Servo to be used in the CD system.

In combination with a CMOS single chip processor TC9432AF a CD system can be composed very simply.

### FEATURES

- Built in amplifier for reference ( $V_{REF}$ ,  $2V_{REF}$ ) supply.
- Built in Auto Laser Power Control circuit.
- Built in RF amplifier.
- Built in focus error amp and tracking error amp.
- Built in sub-beam adder signal amplifier.
- Capable of tracking balance control with TC9432AF.
- Capable of RF gain adjustment circuit with TC9432AF.
- Built in signal amplifier for track counter.
- Capable of 4 times speed operation.
- 24 pin mini flat package.



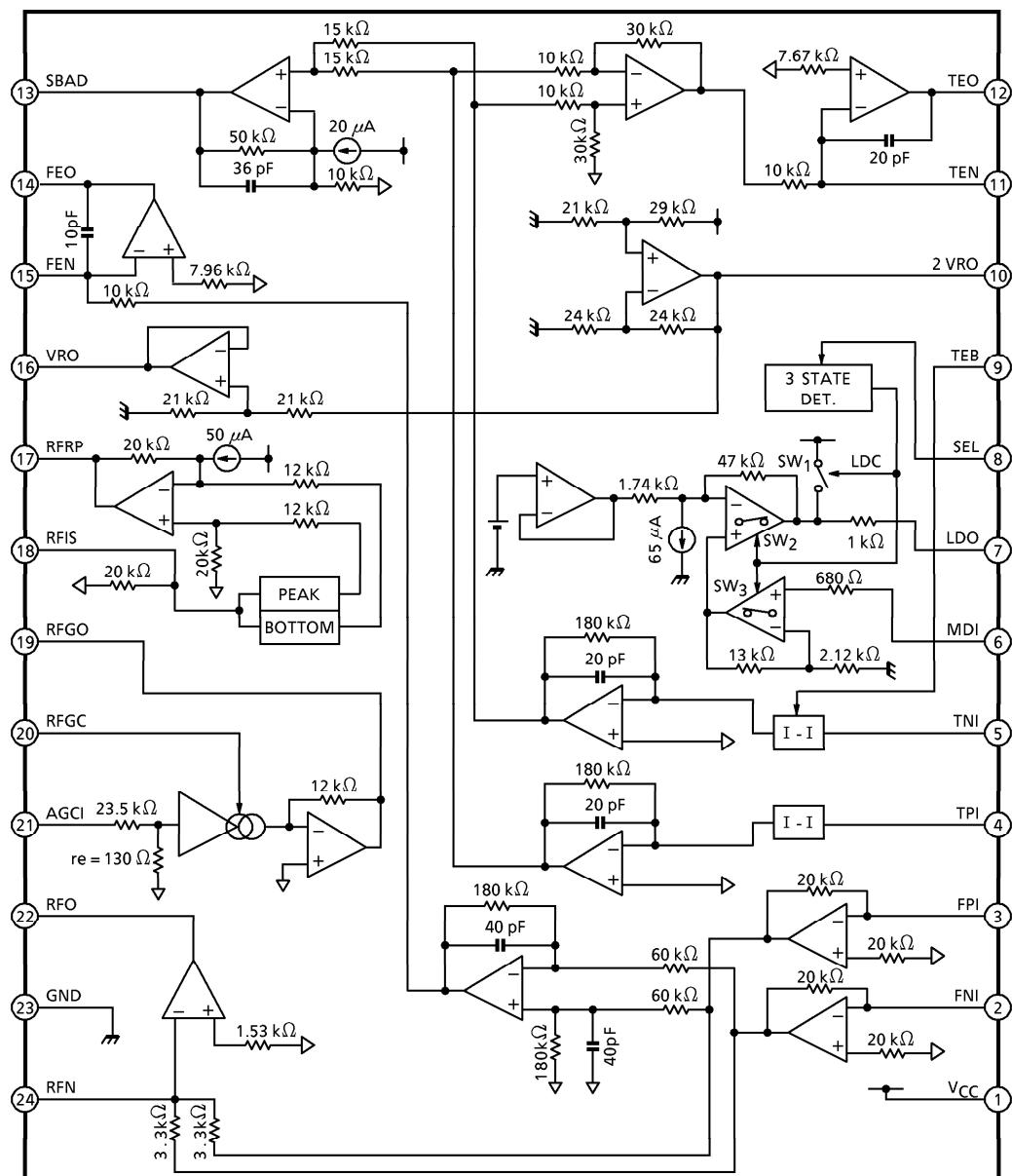
SSOP24-P-300-1.00

Weight : 0.3 g (Typ.)

980910EBA1

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## BLOCK DIAGRAM



SEL	LDC		
	SW1	SW2	SW3
L	ON	OFF	OFF
HiZ	OFF	ON	ON
H	OFF	ON	ON

## PIN FUNCTION

PIN No.	SYMBOL	I / O	FUNCTIONAL DESCRIPTION	REMARK
1	V <sub>CC</sub>	—	Power supply input terminal	—
2	FNI	I	Main beam I-V amp input terminal	Connected to pin diode A, C
3	FPI	I	Main beam I-V amp input terminal	Connected to pin diode B, D
4	TPI	I	Sub beam I-V amp input terminal	Connected to pin diode F
5	TNI	I	Sub beam I-V amp input terminal	Connected to pin diode E
6	MDI	I	Monitor photo diode amp input terminal	Connected to monitor photo diode
7	LDO	O	Laser diode amp output terminal	Connected to laser control circuit
8	SEL	I	Laser diode control signal input terminal and APC circuit ON/OFF control signal input terminal	3 signal input (V <sub>CC</sub> , Hi-Z, GND)
9	TEB	I	Tracking error balance adjustment signal input terminal Controlled by 3 PWM signal (PWM carrier = 88.2 kHz)	3 signal input (2 V <sub>REF</sub> , VR, GND)
10	2VRO	O	Reference voltage (2 V <sub>REF</sub> ) output terminal 2 V <sub>REF</sub> = 4.2 V when V <sub>CC</sub> = 5 V	—
11	TEN	I	TE amp negative input terminal	Connected to TEO through feedback register
12	TEO	O	TE error signal output terminal	—
13	SBAD	O	Sub beam adder signal output terminal	—
14	FEO	O	Focus error signal output terminal	—
15	FEN	I	FE amp negative input terminal	Connected to FEO through feedback register
16	VRO	O	Reference voltage (V <sub>REF</sub> ) output terminal V <sub>REF</sub> = 2.1 V when V <sub>CC</sub> = 5 V	—
17	RFRP	O	Track count signal output terminal	—
18	RFIS	I	RFRP detect circuit input terminal	Connected to RFO through condenser
19	RFGO	O	RF gain signal output terminal	—
20	RGFC	I	RF amplitude adjustment control signal input terminal Controlled by 3 PWM signal (PWM carrier = 88.2 kHz)	3 signal input (2 V <sub>REF</sub> , VR, GND)
21	AGCI	I	RF signal amplitude adjustment amp input terminal	Connected to RFO through condenser
22	RFO	O	RF signal output terminal	—
23	GND	—	Ground terminal	—
24	RFN	I	RF amp negative input terminal	—

**MAXIMUM RATINGS (Ta = 25°C)**

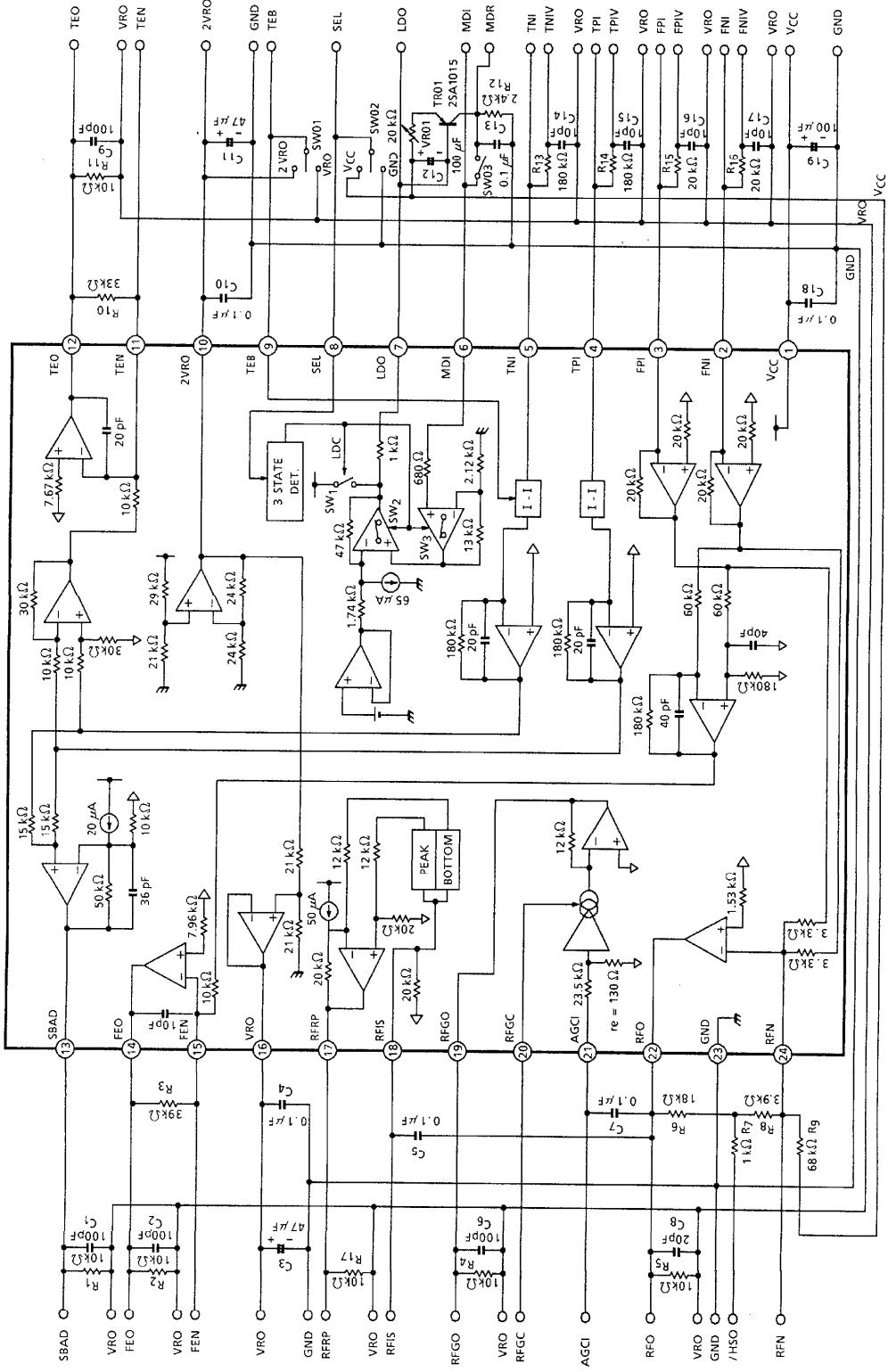
CHARACTERISTIC	SYMBOL	RATING	UNIT
Power Supply Voltage	V <sub>CC</sub>	8	V
Power Dissipation	P <sub>D</sub>	400	mW
Operating Temperature	T <sub>opr</sub>	-40~85	°C
Storage Temperature	T <sub>stg</sub>	-55~150	°C

**ELECTRICAL CHARACTERISTICS (Unless otherwise specified, V<sub>CC</sub> = 5 V, Ta = 25°C)**  
AC CHARACTERISTICS

CHARACTERISTIC		SYMBOL	TEST CIR-CUIT	TEST CONDITION		MIN.	TYP.	MAX.	UNIT
Power Supply	Assured Supply Voltage	V <sub>CC</sub>	1			4.5	5.0	5.5	V
	Power Supply Voltage	I <sub>CC</sub>	1	SEL = V <sub>CC</sub>		18	24	30	mA
Reference Voltage : 2 V <sub>REF</sub>	Reference Voltage	2 VR	1			4.0	4.2	4.4	V
	Output Current	I <sub>OH2</sub>	1	ΔV = -0.1 V		3.0	—	—	mA
	Input Current	I <sub>OL2</sub>	1	ΔV = +0.1 V		0.1	—	—	mA
Reference Voltage : V <sub>REF</sub>	Reference Voltage	VR	1			2.0	2.1	2.2	V
	Reference Voltage Limit	ΔVR	1	2 × VR / 2 VR - 1		-3.0	0.0	+3.0	%
	Output Current	I <sub>OH1</sub>	1	ΔV = -0.1 V		5.0	—	—	mA
	Input Current	I <sub>OL1</sub>	1	ΔV = +0.1 V		5.0	—	—	mA
RF1 FPI (FNI) →RFO	Transfer Resistance	R <sub>T</sub>	1	f = 100 kHz, R <sub>NF</sub> = 22 kΩ		117	130	143	kΩ
	Frequency Characteristic	f <sub>C</sub>	1	-3 dB point		—	5.0	—	MHz
	Output Slew Rate	SR	1	CRFO = 20 pF		10	20	—	V / μs
	Noise / Distortion Rate	THD	1	f = 100 kHz, V <sub>RFO</sub> = 1.2 V <sub>p-p</sub>		—	-40	—	dB
	Upper Limit Output Voltage	V <sub>OH</sub>	1	GND reference		3.6	—	—	V
	Lower Limit Output Voltage	V <sub>OL</sub>	1	GND reference		—	—	0.7	V
	Permissive Load Resistance	R <sub>LM</sub>	1			10	—	—	kΩ
RF2 (AGC) RFO →RFGO	Lower Limit Gain Voltage	G <sub>V1</sub>	1	f = 100 kHz, RF <sub>GC</sub> = 0.6 V		0.66	0.73	0.80	V / V
	Upper Limit Gain Voltage	G <sub>V2</sub>	1	f = 100 kHz, RF <sub>GC</sub> = 3.6 V		1.60	1.75	1.90	V / V
	Frequency Characteristic	f <sub>C</sub>	1	-3 dB point		—	5.0	—	MHz
	Output Slew Rate	SR	1	CR <sub>FGO</sub> = 20 pF		10	20	—	V / μs
	Upper Limit Output Voltage	V <sub>OH</sub>	1	GND reference		3.6	—	—	V
	Lower Limit Output Voltage	V <sub>OL</sub>	1	GND reference		—	—	0.7	V
	Noise / Distortion Rate	THD	1	f = 100 kHz, V <sub>RF<sub>GO</sub></sub> = 1.2 V <sub>p-p</sub>		—	-40	—	dB
	Permissive Load Resistance	R <sub>LM</sub>	1			10	—	—	kΩ
APC MDI →LDO	Gain Voltage	G <sub>V</sub>	1	f = 1 kHz		—	200	—	V / V
	Operation Reference Voltage	V <sub>MDI</sub>	1	VLDO = 3.5 V <sub>DC</sub>		170	178	192	mV
	LD Off Voltage	V <sub>LDO<sub>P</sub></sub>	1	LDC = L, V <sub>CC</sub> reference, SEL = L		-0.7	—	—	V
	Input Vias Current	I <sub>I</sub>	1	V <sub>MDI</sub> = 178 mV		-200	—	+200	nA

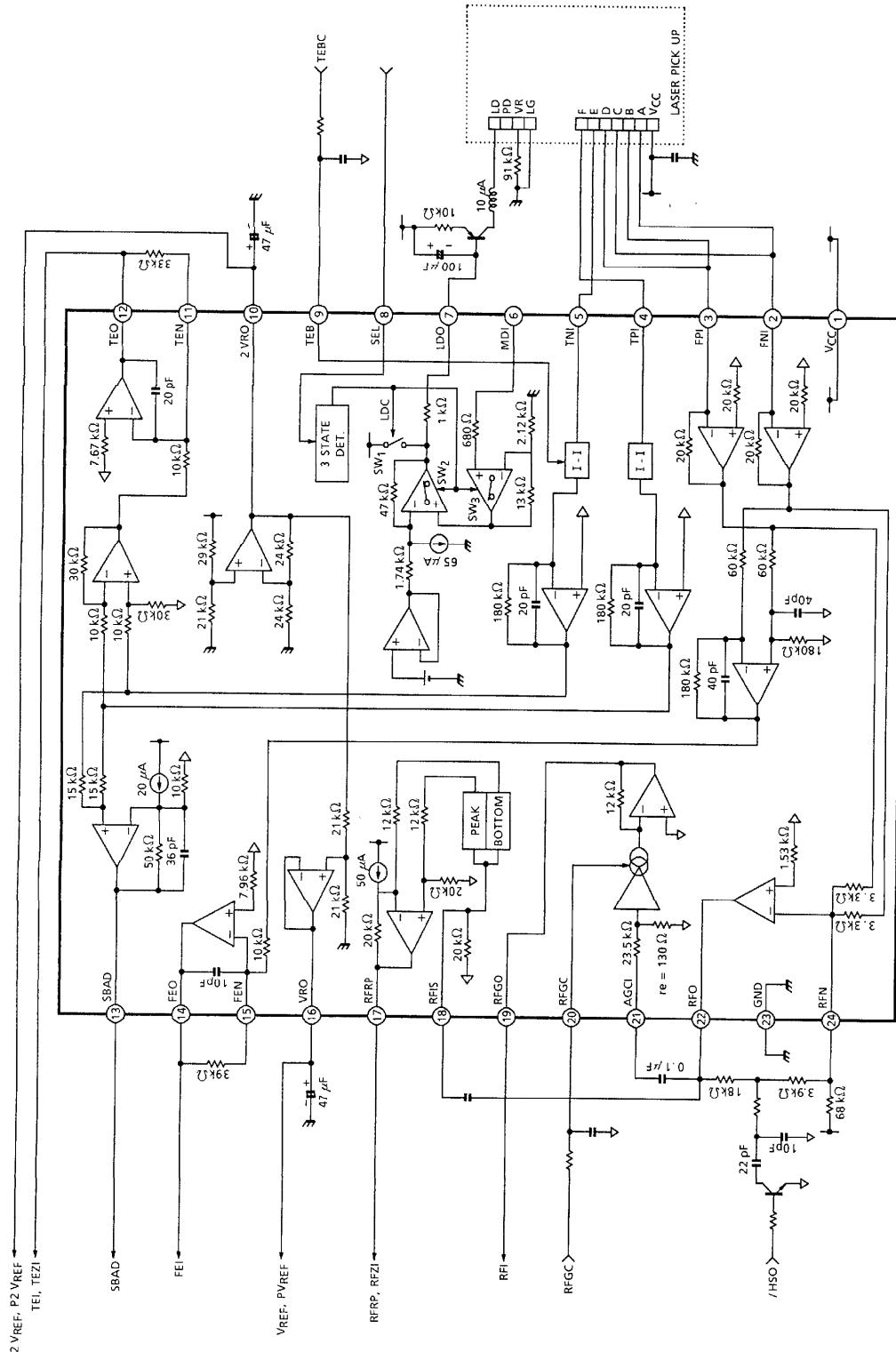
CHARACTERISTIC		SYMBOL	TEST CIR-CUIT	TEST CONDITION		MIN.	TYP.	MAX.	UNIT	
FE FNI (FPI) →FEO		R <sub>T</sub>	1	$f = 1 \text{ kHz}$ , $R_{NF} = 39 \text{ k}\Omega$		198	220	242	$\text{k}\Omega$	
		G <sub>B</sub>	1			-1.0	—	+1.0	$\text{dB}$	
		f <sub>C</sub>	1	-3 dB point		—	22	—	$\text{kHz}$	
		V <sub>OS</sub>	1	VR reference, input open		-30	—	+30	$\text{mV}$	
		THD	1	$f = 1 \text{ kHz}$ , $V_{FEO} = 2.4 \text{ V}_{\text{p-p}}$		—	-40	—	$\text{dB}$	
		V <sub>OH</sub>	1	GND reference		3.8	—	—	$\text{V}$	
		V <sub>OL</sub>	1	GND reference		—	—	0.5	$\text{V}$	
		R <sub>LM</sub>	1			10	—	—	$\text{k}\Omega$	
TE TPI (TNI) →TEO		R <sub>T</sub>	1	$f = 1 \text{ kHz}$ , TEB = VR, $R_{NF} = 33 \text{ k}\Omega$		1.53	1.70	1.87	$\text{M}\Omega$	
		Transfer Resistance Range		$\Delta R_T$	TEB = VR reference TEB = GND TEB = 2 VR	35	45	55	%	
		Max. Transfer Resistance				-55	-45	-35	%	
		Gain Balance	GB	1		-1.0	—	+1.0	$\text{dB}$	
		Frequency Characteristic				—	44	—	$\text{kHz}$	
		Cut-Off Frequency 1	f <sub>C1</sub>	—		240	—	$\text{kHz}$		
		Cut-Off Frequency 2	f <sub>C2</sub>	—		—	—	$\text{kHz}$		
		Output Offset Voltage	V <sub>OS</sub>	1	VR reference, input open		-80	—	+80	$\text{mV}$
		Noise / Distortion Rate	THD	1	$f = 1 \text{ kHz}$ , $V_{TEO} = 2.0 \text{ V}_{\text{p-p}}$		—	-40	—	$\text{dB}$
		Upper Limit Output Voltage	V <sub>OH</sub>	1	GND reference		3.8	—	—	$\text{V}$
SBAD TPI (TNI) →SBAD		Lower Limit Output Voltage	V <sub>OL</sub>	1	GND reference		—	—	0.5	$\text{V}$
		Permissive Load Resistance	R <sub>LM</sub>	1			10	—	—	$\text{k}\Omega$
		Transfer Resistance	R <sub>T</sub>	1	$f = 1 \text{ kHz}$ , TEB = VR		416	520	624	$\text{k}\Omega$
		Frequency Characteristic	f <sub>C</sub>	1	-3 dB point		—	44	—	$\text{kHz}$
		Noise / Distortion Rate	THD	1	$f = 1 \text{ kHz}$ , $V_{SBAD} = 1.5 \text{ V}_{\text{p-p}}$		—	-40	—	$\text{dB}$
		Operation Reference Voltage		V <sub>OPR</sub>	TNI / TPI = VR, VR reference TNI / TPI = Hiz, VR reference	-1.1	-1.0	-0.9	$\text{V}$	
RFRP RFIS→RFRP		Upper Limit Output Voltage	V <sub>OH</sub>	1		-1.2	-1.1	-1.0		
		Permissive Load Resistance	R <sub>LM</sub>	1			10	—	—	$\text{k}\Omega$
		Gain Voltage	G <sub>V</sub>	1			1.37	1.46	1.54	$\text{V/V}$
		Detection Frequency Characteristic	f <sub>C</sub>	—	SEL = V <sub>CC</sub>		—	100	—	$\text{kHz}$
		Operation Reference Voltage 1	V <sub>OPR1</sub>	1	VR reference No signal		-1.1	-1.0	-0.9	$\text{V}$
		Operation Reference Voltage 2	V <sub>OPR2</sub>	1	VR reference 700 kHz, 1.2 V <sub>pp</sub>		+0.65	+0.75	+0.85	$\text{V}$
		Permissive Load Resistance	R <sub>LM</sub>	1			10	—	—	$\text{k}\Omega$

## TEST CIRCUIT



TA2109F-6

## APPLICATION CIRCUIT

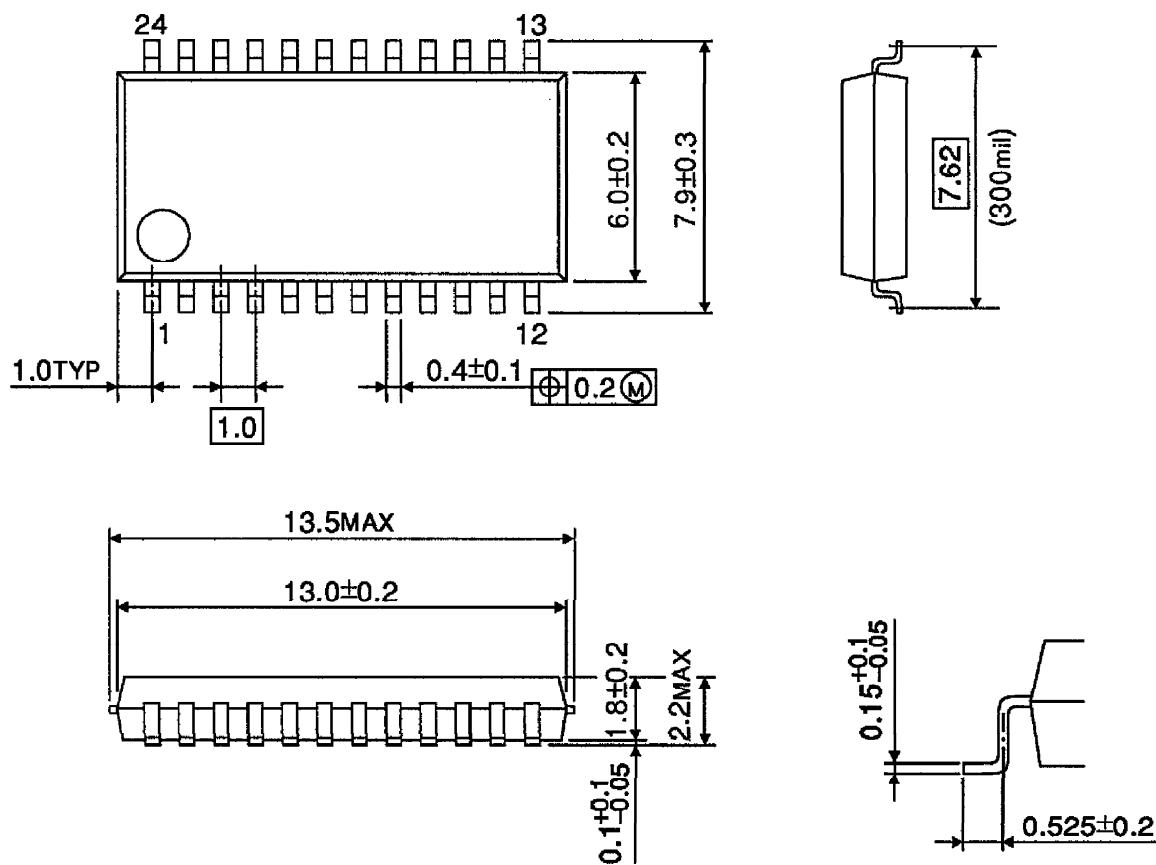


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## OUTLINE DRAWING

SSOP24-P-300-1.00

Unit : mm



Weight : 0.3 g (Typ.)